

# DATA SHEET

**74F85**

4-bit magnitude comparator

Product specification

1994 Sep 27

IC15 Data Handbook

**Philips Semiconductors**



**PHILIPS**

# 4-bit magnitude comparator

# 74F85

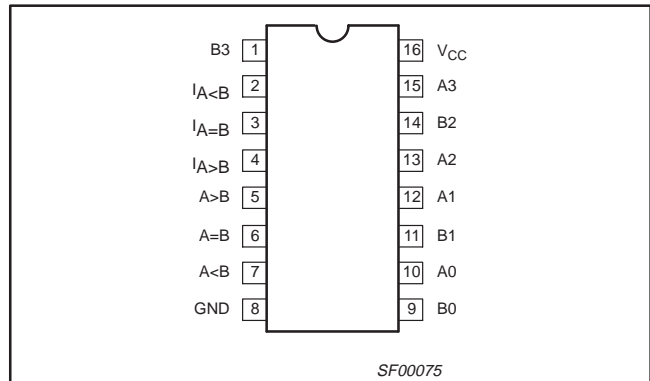
## FEATURES

- High-impedance NPN base inputs for reduced loading (20µA in High and Low states)
- Magnitude comparison of any binary words
- Serial or parallel expansion without extra gating

## DESCRIPTION

The 74F85 is a 4-bit magnitude comparator that can be expanded to almost any length. It compares two 4-bit binary, BCD, or other monotonic codes and presents the three possible magnitude results at the outputs. The 4-bit inputs are weighted (A0–A3) and (B0–B3) where A3 and B3 are the most significant bits. The operation of the 74F85 is described in the Function Table, showing all possible logic conditions. The upper part of the table describes the normal operation under all conditions that will occur in a single device or in a series expansion scheme. In the upper part of the table the three outputs are mutually exclusive. In the lower part of the table, the outputs reflect the feed-forward conditions that exist in the parallel expansion scheme. The expansion inputs  $I_{A>B}$ ,  $I_{A=B}$  and  $I_{A<B}$  are the least significant bit positions. When used for series expansion, the A>B, A=B and A<B outputs of the least significant word are connected to the corresponding  $I_{A>B}$ ,  $I_{A=B}$  and  $I_{A<B}$  inputs of the next higher stage. Stages can be added in this manner to any length, but a propagation delay penalty of about 15ns is added with each additional stage. For proper operation, the expansion inputs of the least significant word should be tied as follows:  $I_{A>B}$  = Low,  $I_{A=B}$  = High, and  $I_{A<B}$  = Low.

## PIN CONFIGURATION



TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F85	7.0ns	40mA

## ORDERING INFORMATION

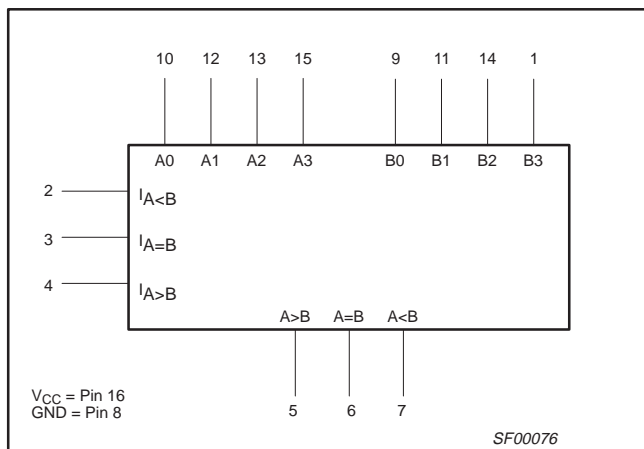
DESCRIPTION	COMMERCIAL RANGE $V_{CC} = 5V \pm 10\%$ , $T_{amb} = 0^{\circ}C$ to $+70^{\circ}C$	PKG DWG #
16-pin plastic DIP	N74F85N	SOT38-4
16-pin plastic SO	N74F85D	SOT162-1

## INPUT AND OUTPUT LOADING AND FAN OUT TABLE

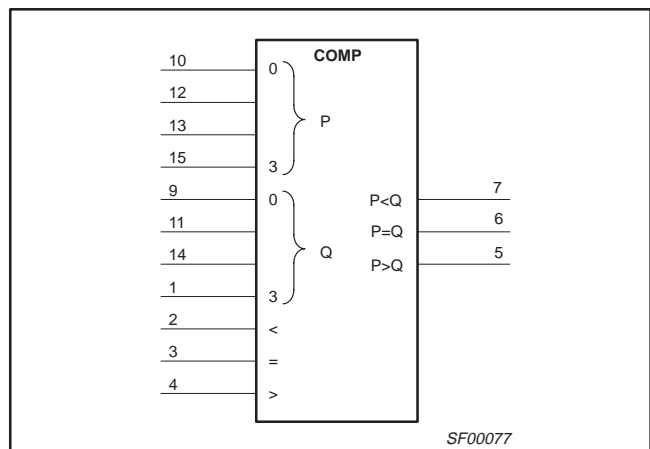
PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
A0–A3	Comparing inputs	1.0/0.033	20µA/20µA
B0–B3	Comparing inputs	1.0/0.033	20µA/20µA
$I_{A<B}$ , $I_{A=B}$ , $I_{A>B}$	Expansion inputs (active High)	1.0/0.033	20µA/20µA
A<B, A=B, A>B	Data outputs (active High)	50/33	1.0mA/20mA

**NOTE:** One (1.0) FAST unit load is defined as: 20µA in the High state and 0.6mA in the Low state.

## LOGIC SYMBOL



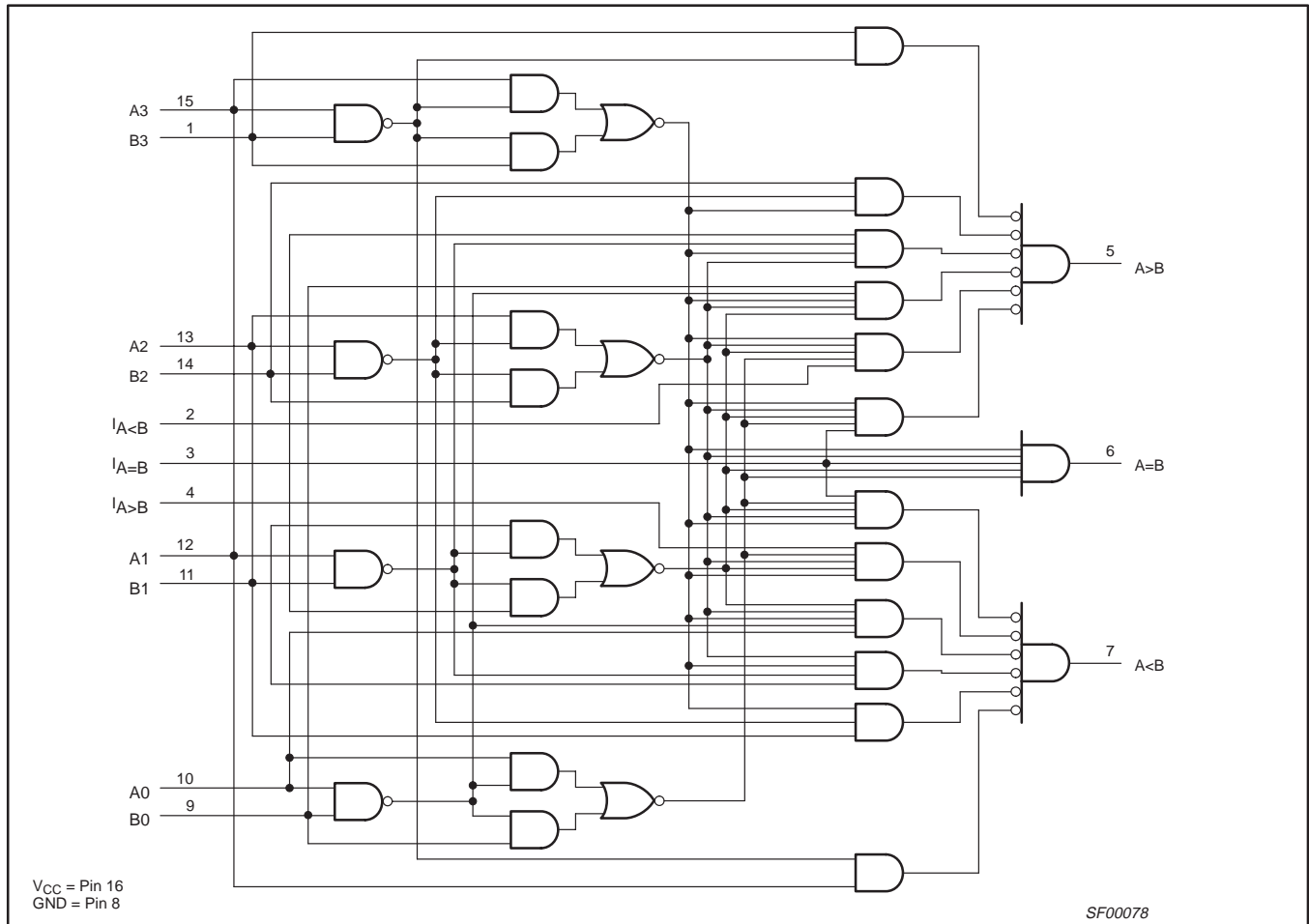
## IEC/IEEE SYMBOL



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## LOGIC DIAGRAM



## FUNCTION TABLE

COMPARING INPUTS				EXPANSION INPUTS			OUTPUTS		
A3,B3	A2,B2	A1,B1	A0,B0	I <sub>A&gt;B</sub>	I <sub>A&lt;B</sub>	I <sub>A=B</sub>	A>B	A<B	A=B
A3>B3	X	X	X	X	X	X	H	L	L
A3<B3	X	X	X	X	X	X	L	H	L
A3=B3	A2>B2	X	X	X	X	X	H	L	L
A3=B3	A2<B2	X	X	X	X	X	L	H	L
A3=B3	A2=B2	A1>B1	X	X	X	X	H	L	L
A3=B3	A2=B2	A1<B1	X	X	X	X	L	H	L
A3=B3	A2=B2	A1=B1	A0>B0	X	X	X	H	L	L
A3=B3	A2=B2	A1=B1	A0<B0	X	X	X	L	H	L
A3=B3	A2=B2	A1=B1	A0=B0	H	L	L	H	L	L
A3=B3	A2=B2	A1=B1	A0=B0	L	H	L	L	H	L
A3=B3	A2=B2	A1=B1	A0=B0	L	L	H	L	L	H
A3=B3	A2=B2	A1=B1	A0=B0	X	X	H	L	L	H
A3=B3	A2=B2	A1=B1	A0=B0	H	H	L	L	L	L
A3=B3	A2=B2	A1=B1	A0=B0	L	L	L	H	H	L

H = High voltage level  
L = Low voltage level  
X = Don't care

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## APPLICATION

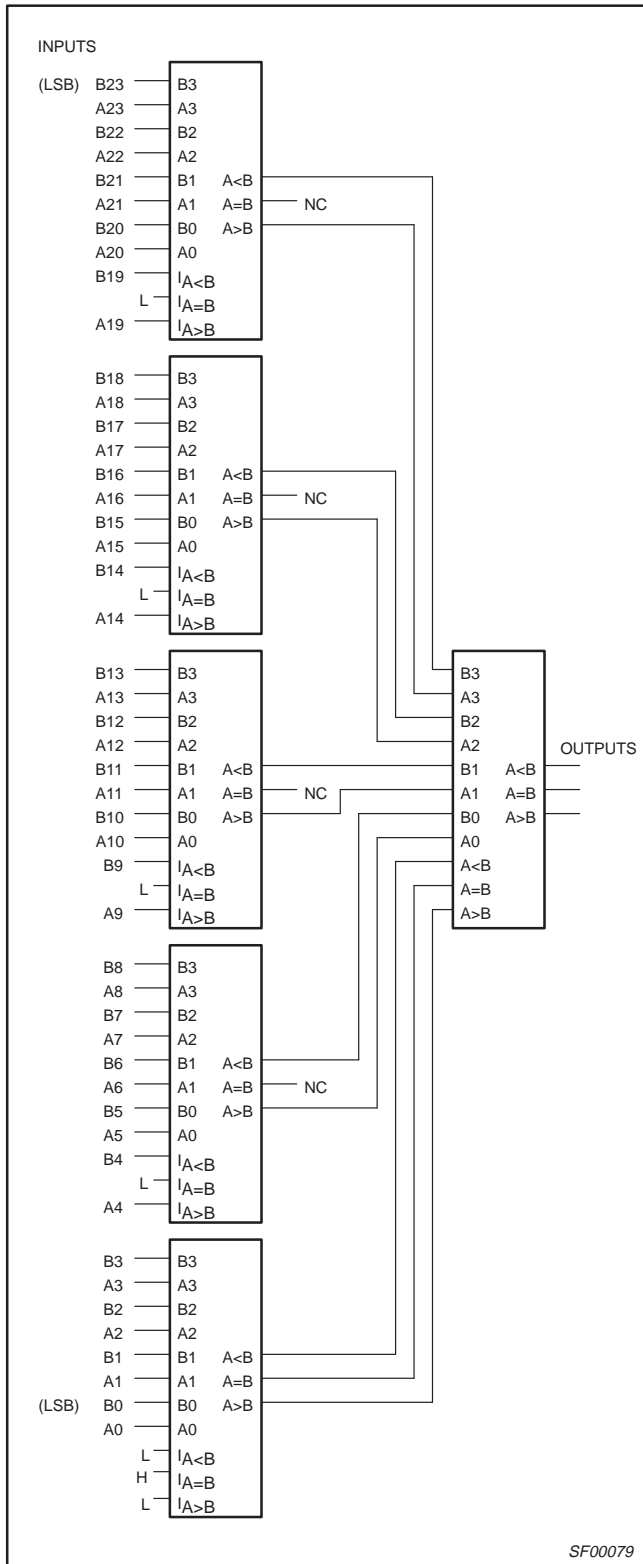


Figure 1. Comparison of Two 24-Bit Words

The parallel expansion scheme shown in Figure 1 demonstrates the most efficient general use of these comparators. The expansion inputs can be used as a fifth input bit position except on the least significant device, which must be connected as in the serial scheme. The expansion inputs used by labeling  $I_{A>B}$  as an "A" input,  $I_{A<B}$  as a "B" input and setting  $I_{A=B}$  = Low. The 74F85 can be used as a 5-bit comparator only when the outputs are used to drive the (A0–A3) and (B0–B3) inputs of another 74F85 device. The parallel technique can be expanded to any number of bits as shown in Table 1.

Table 1.

WORD LENGTH	NUMBER OF PACKAGES	TYPICAL SPEEDS 74F
1–4 bits	1	12ns
5–24 bits	2–6	22ns
25–120 bits	8–31	34ns

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**ABSOLUTE MAXIMUM RATINGS**

(Operation beyond the limits set forth in this table may impair the useful life of the device.  
Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V <sub>CC</sub>	Supply voltage	-0.5 to +7.0	V
V <sub>IN</sub>	Input voltage	-0.5 to +7.0	V
I <sub>IN</sub>	Input current	-30 to +5	mA
V <sub>OUT</sub>	Voltage applied to output in High output state	-0.5 to V <sub>CC</sub>	V
I <sub>OUT</sub>	Current applied to output in Low output state	40	mA
T <sub>amb</sub>	Operating free-air temperature range	0 to +70	°C
T <sub>stg</sub>	Storage temperature range	-65 to +150	°C

**RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	LIMITS			UNIT
		MIN	NOM	MAX	
V <sub>CC</sub>	Supply voltage	4.5	5.0	5.5	V
V <sub>IH</sub>	High-level input voltage	2.0			V
V <sub>IL</sub>	Low-level input voltage			0.8	V
I <sub>IK</sub>	Input clamp current			-18	mA
I <sub>OH</sub>	High-level output current			-1	mA
I <sub>OL</sub>	Low-level output current			20	mA
T <sub>amb</sub>	Operating free-air temperature range	0		+70	°C

**DC ELECTRICAL CHARACTERISTICS**

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER	TEST CONDITIONS <sup>1</sup>	LIMITS			UNIT	
			MIN	TYP <sup>2</sup>	MAX		
V <sub>OH</sub>	High-level output voltage	V <sub>CC</sub> = MIN, V <sub>IL</sub> = MAX V <sub>IH</sub> = MIN, I <sub>OH</sub> = MAX	±10%V <sub>CC</sub>	2.5		V	
			±5%V <sub>CC</sub>	2.7	3.4		
V <sub>OL</sub>	Low-level output voltage	V <sub>CC</sub> = MIN, V <sub>IL</sub> = MAX V <sub>IH</sub> = MIN, I <sub>OL</sub> = MAX	±10%V <sub>CC</sub>		0.30	V	
			±5%V <sub>CC</sub>		0.30		
V <sub>IK</sub>	Input clamp voltage	V <sub>CC</sub> = MIN, I <sub>I</sub> = I <sub>IK</sub>		-0.73	-1.2	V	
I <sub>I</sub>	Input current at maximum input voltage	V <sub>CC</sub> = 0.0V, V <sub>I</sub> = 7.0V			100	μA	
I <sub>IH</sub>	High-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 2.7V			20	μA	
I <sub>IL</sub>	Low-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.5V			-20	μA	
I <sub>OS</sub>	Short-circuit output current <sup>3</sup>	V <sub>CC</sub> = MAX		-60	-150	mA	
I <sub>CC</sub>	Supply current (total)	V <sub>CC</sub> = MAX	V <sub>IN</sub> = GND An = Bn = I <sub>A=B</sub> = GND, I <sub>A&gt;B</sub> = I <sub>A&lt;B</sub> = 4.5V		36	50	mA
					40	54	

**NOTES:**

- For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
- All typical values are at V<sub>CC</sub> = 5V, T<sub>amb</sub> = 25°C.
- Not more than one output should be shorted at a time. For testing I<sub>OS</sub>, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I<sub>OS</sub> tests should be performed last.

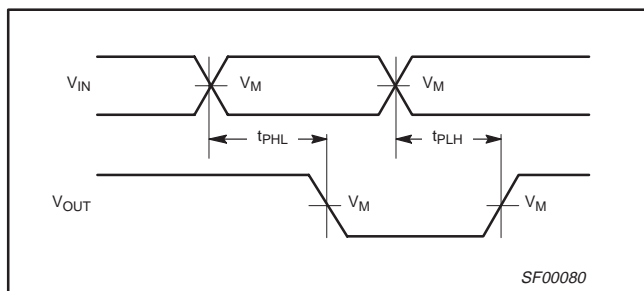
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## AC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITION	LIMITS					UNIT
			$V_{CC} = +5.0V$ $T_{amb} = +25^{\circ}C$ $C_L = 50pF, R_L = 500\Omega$			$V_{CC} = +5.0V \pm 10\%$ $T_{amb} = 0^{\circ}C \text{ to } +70^{\circ}C$ $C_L = 50pF, R_L = 500\Omega$		
			MIN	TYP	MAX	MIN	MAX	
$t_{PLH}$ $t_{PHL}$	Propagation delay A or B to A<B, A>B	Waveform 1 3 logic levels	6.0 7.0	8.5 9.5	11.0 14.0	5.5 6.5	13.0 15.5	ns
$t_{PLH}$ $t_{PHL}$	Propagation delay A or B to A=B	Waveform 1 4 logic levels	6.5 7.0	9.0 9.5	11.5 14.0	6.0 6.5	14.0 14.5	ns
$t_{PLH}$ $t_{PHL}$	Propagation delay $I_{A<B}$ and $I_{A=B}$ to A>B	Waveform 1 1 logic level	3.0 3.0	5.0 6.0	7.5 9.0	2.5 2.5	9.0 10.0	ns
$t_{PLH}$ $t_{PHL}$	Propagation delay $I_{A=B}$ to A=B	Waveform 1 2 logic levels	2.5 3.5	4.5 7.5	7.0 10.0	2.0 2.5	9.0 12.0	ns
$t_{PLH}$ $t_{PHL}$	Propagation delay $I_{A>B}$ and $I_{A=B}$ to A<B	Waveform 1 1 logic level	3.0 3.0	5.0 6.0	8.0 9.0	3.0 2.0	9.5 9.5	ns

## AC WAVEFORMS



Waveform 1. Propagation Delay Input to Output

**NOTE:**

For all waveforms,  $V_M = 1.5V$ .

## TEST CIRCUIT AND WAVEFORMS

**Test Circuit for Totem-Pole Outputs**

**Input Pulse Definition**

**DEFINITIONS:**

- $R_L$  = Load resistor; see AC ELECTRICAL CHARACTERISTICS for value.
- $C_L$  = Load capacitance includes jig and probe capacitance; see AC ELECTRICAL CHARACTERISTICS for value.
- $R_T$  = Termination resistance should be equal to  $Z_{OUT}$  of pulse generators.

family	INPUT PULSE REQUIREMENTS					
	amplitude	$V_M$	rep. rate	$t_w$	$t_{TLH}$	$t_{THL}$
74F	3.0V	1.5V	1MHz	500ns	2.5ns	2.5ns

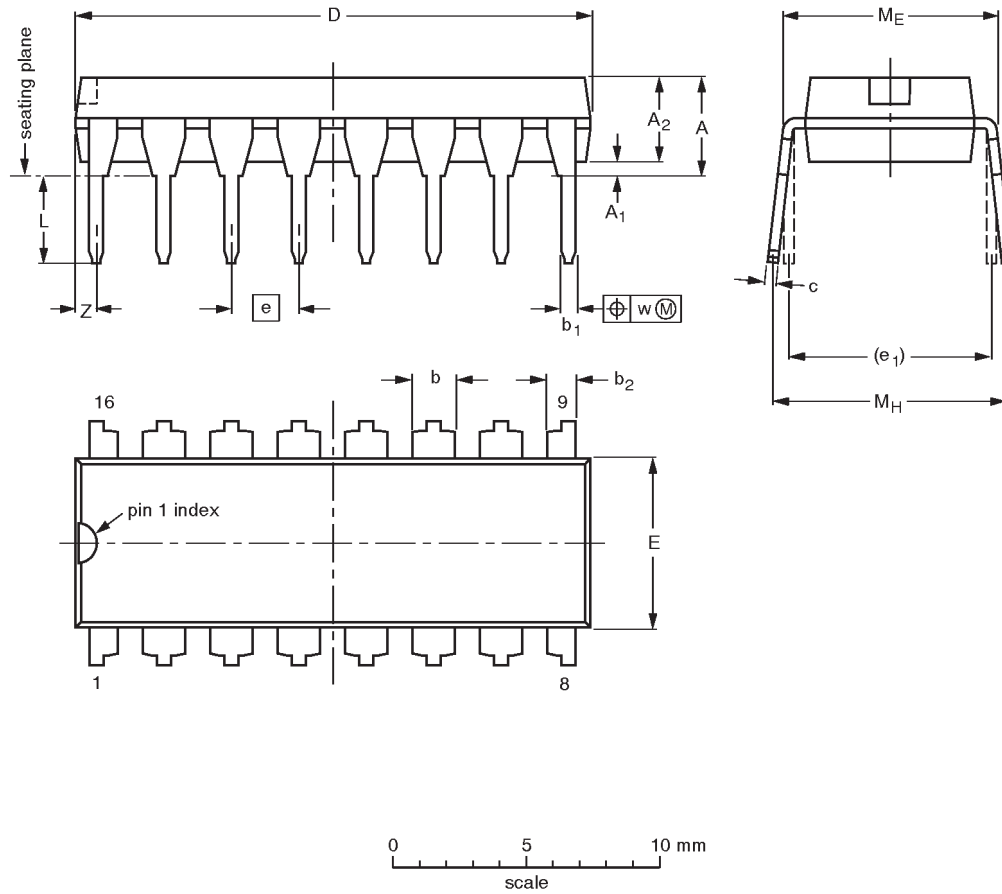
SF00006

# 4-bit magnitude comparator

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DIP16: plastic dual in-line package; 16 leads (300 mil)

SOT38-4



**DIMENSIONS (inch dimensions are derived from the original mm dimensions)**

UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	b <sub>2</sub>	c	D <sup>(1)</sup>	E <sup>(1)</sup>	e	e <sub>1</sub>	L	M <sub>E</sub>	M <sub>H</sub>	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	1.25 0.85	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	0.76
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.049 0.033	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.030

**Note**

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

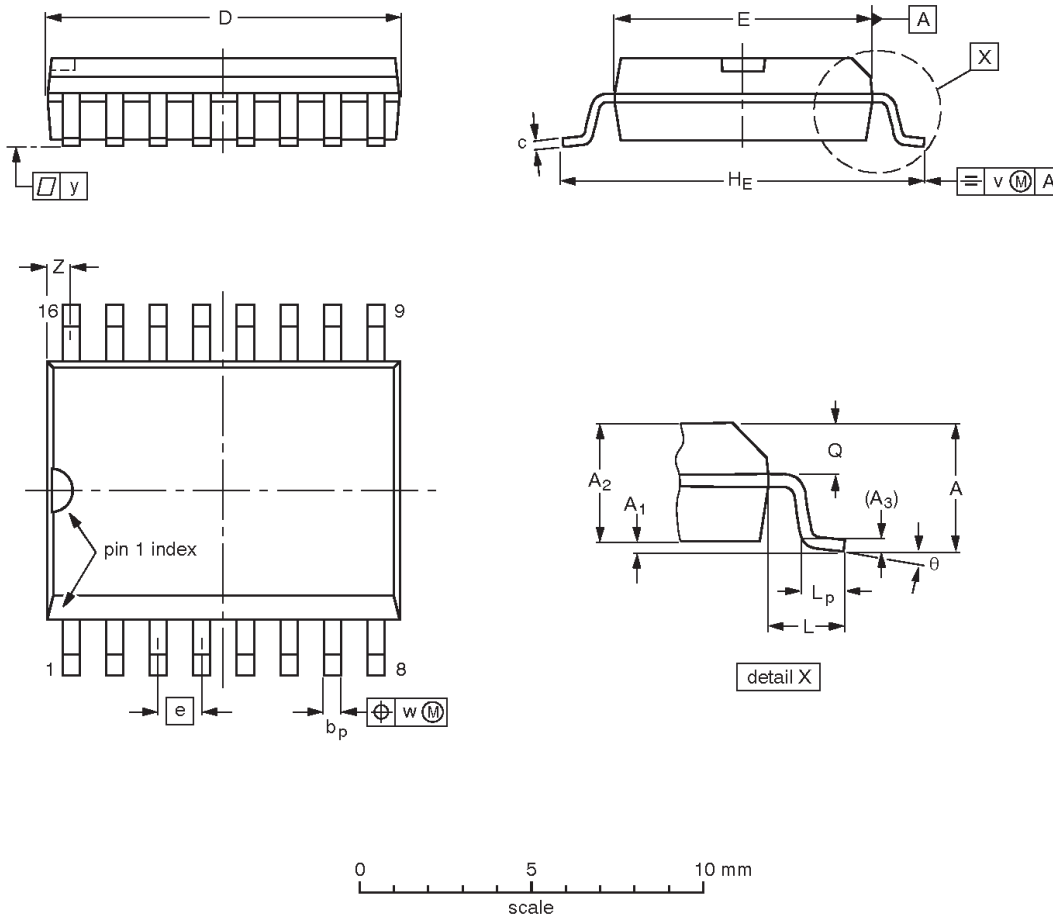
OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT38-4						-92-11-17 95-01-14

# 4-bit magnitude comparator

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SO16: plastic small outline package; 16 leads; body width 7.5 mm

SOT162-1



**DIMENSIONS (inch dimensions are derived from the original mm dimensions)**

UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	c	D <sup>(1)</sup>	E <sup>(1)</sup>	e	H <sub>E</sub>	L	L <sub>p</sub>	Q	v	w	y	z <sup>(1)</sup>	θ
mm	2.65	0.30 0.10	2.45 2.25	0.25	0.49 0.36	0.32 0.23	10.5 10.1	7.6 7.4	1.27	10.65 10.00	1.4	1.1 0.4	1.1 1.0	0.25	0.25	0.1	0.9 0.4	8° 0°
inches	0.10	0.012 0.004	0.096 0.089	0.01	0.019 0.014	0.013 0.009	0.41 0.40	0.30 0.29	0.050	0.419 0.394	0.055	0.043 0.016	0.043 0.039	0.01	0.01	0.004	0.035 0.016	

**Note**

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT162-1	075E03	MS-013AA				95-01-24 97-05-22



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## NOTES

## 4-bit magnitude comparator

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## Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

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Philips Semiconductors  
811 East Arques Avenue  
P.O. Box 3409  
Sunnyvale, California 94088-3409  
Telephone 800-234-7381

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